



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

MAY 03 2005

In re Patent Application of:
MEARS ET AL.

Serial No. 10/603,621

Confirmation No. 4467

Filing Date: JUNE 26, 2003

For: METHODS OF FABRICATING SEMI-
CONDUCTOR STRUCTURES HAVING
IMPROVED CONDUCTIVITY EFFECTIVE
MASS

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)
) Examiner: H. Jey TSAT
)
) Art Unit: 2812
)
) Attorney Docket:
62604
)

CITATION UNDER 37 CFR §1.97

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Attached is Form PTO-1449 listing several references for consideration in the examination of the above-identified application. In accordance with current USPTO procedures published 05 AUG. 2003, in 1276 OG 55, copies of the U.S. patent documents cited in the form 1449A are not attached. The undersigned would be happy to provide copies of these references if requested. Copies of non-U.S. patent references, if any, are attached. It is requested that these references be considered by the Examiner and officially made of record in accordance with the provisions of 37 CFR §1.97 and Section 609 of the MPEP.

Respectfully submitted,

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SUBSTITUTE FORM PTO-1449A LIST OF PATENTS AND APPLICANT'S INFORMATION DISCLOSURE STATEMENTS		Atty Docket: Serial No.: Applicant: Filing Date: Group:	62604 10/603,621 MEARS ET AL. 6/26/03 2818
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MAY 03 2005

U.S. PATENT DOCUMENTS						
Examiner Initials	Document Number	Date	Name	Class	Sub Class	Filing Date
	AA	4,882,609	11/21/89	Schubert et al.	357	22
	AB	5,081,513	1/14/92	Jackson et al.	357	23.7
	AC	5,606,177	2/25/97	Wallace et al.	257	25
	AD	6,255,150	7/3/01	Wilk et al.	438	191
	AE	4,908,678	3/13/90	Yamazaki	357	4
	AF					
	AG					
	AH					
	AI					
	AJ					
	AK					
	AL					
FOREIGN PATENT DOCUMENTS						
	Document Number	Date	Country	Class	Sub Class	Translation
	AM	0 843 361	5/20/98	EP	H01L29	76
	AN					
	AO					
	AP					
OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)						
	AQ	Patent Abstracts of Japan, Vol. 012, No. 080 (E-590), 12 March 1988 & JP 62 219665 A (Fujitsu Ltd), 26 September 1987 abstract				
	AR	Patent Abstracts of Japan, Vol. 010, No.179 (E-414), 24 June 1986 & JP 61 027681 A (Res Dev Corp of Japan), 7 February 1986 abstract				
	AS					

EXAMINER:	DATE CONSIDERED:
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609;
 Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.